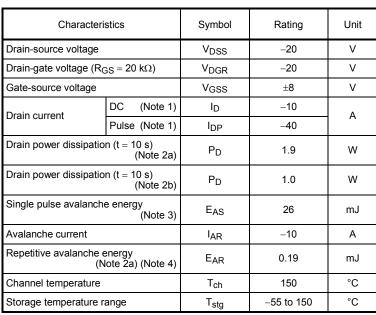
TOSHIBA Field Effect Transistor Silicon P Channel MOS Type (U-MOS IV)

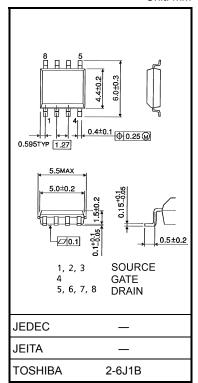
# **TPC8115**

Lithium Ion Battery Applications Notebook PC Applications Portable Equipment Applications

- Small footprint due to small and thin package
- Low drain-source ON resistance:  $R_{DS}$  (ON) = 6.5 m $\Omega$  (typ.)
- High forward transfer admittance:  $|Y_{fs}| = 40 \text{ S} (typ.)$
- Low leakage current:  $I_{DSS} = -10 \ \mu A \ (max) \ (V_{DS} = -20 \ V)$
- Enhancement mode:  $V_{th}$  = -0.5 to -1.2 V ( $V_{DS}$  = -10 V,  $I_D$  = -1 mA)

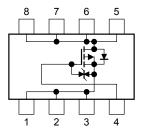


#### Absolute Maximum Ratings (Ta = 25°C)



Weight: 0.080 g (typ.)

#### **Circuit Configuration**



Note: (Note 1), (Note 2), (Note 3) and (Note 4): See the next page.

Using continuously under heavy loads (e.g. the application of high temperature/current/voltage and the significant change in temperature, etc.) may cause this product to decrease in the reliability significantly even if the operating conditions (i.e. operating temperature/current/voltage, etc.) are within the absolute maximum ratings. Please design the appropriate reliability upon reviewing the Toshiba Semiconductor Reliability Handbook ("Handling Precautions"/Derating Concept and Methods) and individual reliability data (i.e. reliability test report and estimated failure rate, etc.).

This transistor is an electrostatic-sensitive device. Please handle with caution.

2006-11-15

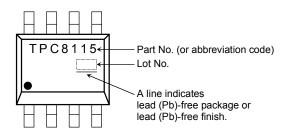
www.DataSheet4U.com

Unit: mm

#### **Thermal Characteristics**

Characteristics	Symbol	Max	Unit
Thermal resistance, channel to ambient (t = 10 s) (Note 2a)	R <sub>th (ch-a)</sub>	65.8	°C/W
Thermal resistance, channel to ambient (t = 10 s) (Note 2b)	R <sub>th (ch-a)</sub>	125	°C/W

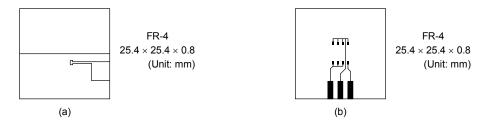
#### Marking (Note 5)



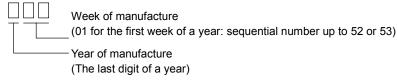
Note 1: Ensure that the channel temperature does not exceed 150°C.

Note 2:

(a) Device mounted on a glass-epoxy board (a) (b) Device mounted on a glass-epoxy board (b)



- Note 3:  $V_{DD} = -16$  V,  $T_{ch} = 25^{\circ}$ C (initial), L = 0.2 mH,  $R_G = 25 \Omega$ ,  $I_{AR} = -10$ A
- Note 4: Repetitive rating; pulse width limited by maximum channel temperature
- Note 5: on lower left of the marking indicates Pin 1.
  - Weekly code: (Three digits)

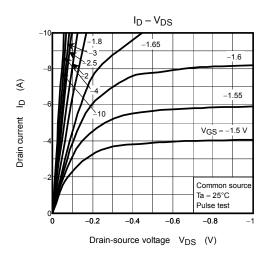


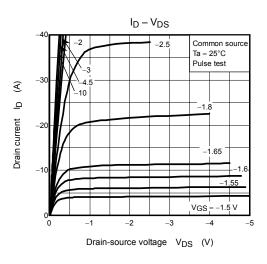
#### Electrical Characteristics (Ta = 25°C)

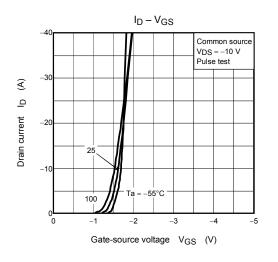
Characteristics		Symbol	Test Condition	Min	Тур.	Max	Unit	
Gate leakage current		I <sub>GSS</sub>	$V_{GS} = \pm 8 \text{ V},  V_{DS} = 0 \text{ V}$		_	±10	μA	
Drain cut-OFF current		I <sub>DSS</sub>	$V_{DS} = -20 \text{ V}, \text{ V}_{GS} = 0 \text{ V}$	_	_	-10	μA	
Drain-source breakdown voltage		V (BR) DSS	$I_D = -10$ mA, $V_{GS} = 0$ V	-20	—	_	V	
		V (BR) DSX	$I_D = -10$ mA, $V_{GS} = 8$ V	-4	_		v	
Gate threshold voltage		V <sub>th</sub>	$V_{DS} = -10 \text{ V}, \text{ I}_{D} = -200 \mu \text{ A}$	-0.5	_	-1.2	V	
Drain-source ON resistance			$V_{GS} = -1.8 \text{ V}, \text{ I}_{D} = -5.0 \text{ A}$		15	30	mΩ	
		R <sub>DS (ON)</sub>	$V_{GS} = -2.5 \text{ V}, \text{ I}_{D} = -5.0 \text{ A}$	_	9.0	14		
			$V_{GS} = -4.5 \text{ V}, \text{ I}_{D} = -5.0 \text{ A}$	_	6.5	10		
Forward transfer admittance		Y <sub>fs</sub>	$V_{DS} = -10 \text{ V}, \text{ I}_{D} = -5.0 \text{ A}$	20	40	_	S	
Input capacitance		C <sub>iss</sub>	V <sub>DS</sub> = -10 V, V <sub>GS</sub> = 0 V, f = 1 MHz	_	9130	_	pF	
Reverse transfer capacitance		C <sub>rss</sub>		_	1020	_		
Output capacitance		C <sub>oss</sub>		_	1110	_		
Switching time	Rise time	tr	$V_{GS} \xrightarrow[-5]{0} V \xrightarrow[-5]{0} V_{OUT}$		14	_	ns	
	Turn-ON time	t <sub>on</sub>			26	_		
	Fall time	t <sub>f</sub>			228	_		
	Turn-OFF time	t <sub>off</sub>	$\label{eq:DD} \begin{split} V_{DD}\simeq -10~V\\ Duty \leq 1\%,~t_W=10~\mu s \end{split}$	_	666	_		
Total gate charge (gate-source plus gate-drain)		Qg	$V_{DD} \simeq -16 \text{ V}, \text{ V}_{GS} = -5 \text{ V},$	_	115		nC	
Gate-source charge 1		Q <sub>gs1</sub>	$I_{\rm D} = -10 \rm{A}$		18	_		
Gate-drain ("miller") charge		Q <sub>gd</sub>			34	_		

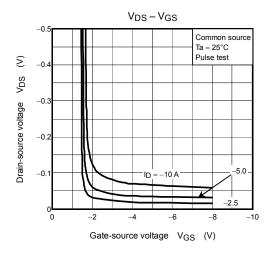
#### Source-Drain Ratings and Characteristics ( $Ta = 25^{\circ}C$ )

Characteristics		Symbol	Test Condition	Min	Тур.	Max	Unit	
Drain reverse current	Pulse	(Note 1)	I <sub>DRP</sub>	—	_	_	-40	А
Forward voltage (diode) VD		V <sub>DSF</sub>	$I_{DR} = -10 \text{ A}, V_{GS} = 0 \text{ V}$			1.2	V	

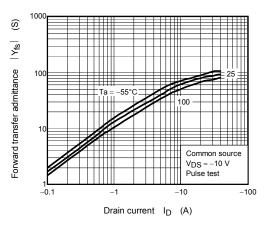




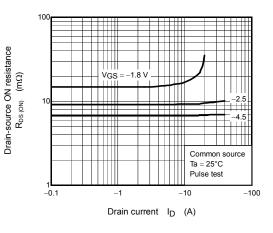


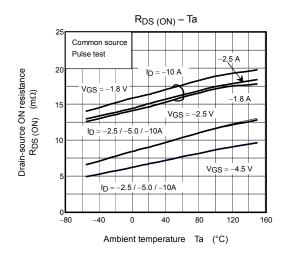


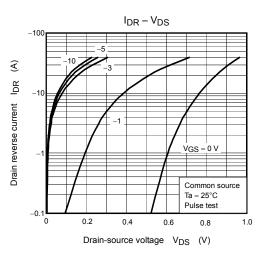


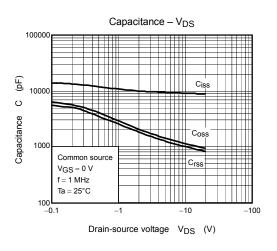


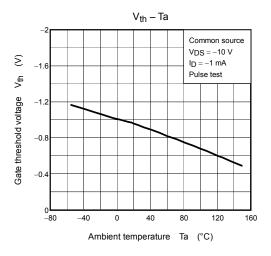


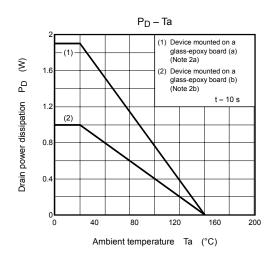


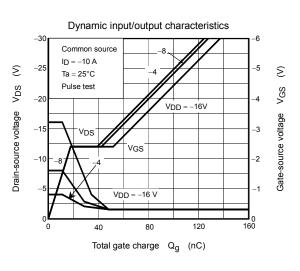


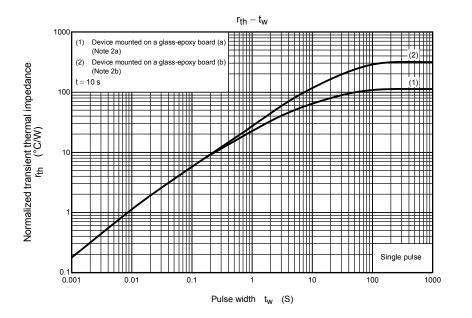












Safe operating area -100 ID max (pulse) ms 10 ms ₹ -10 <u>\_</u> Drain current Single pulse Ta = 25°C Curves must be derated linearly with increase in temperature. VDSS max -0.1 -0.1 -1 -10 -100 Drain-source voltage V<sub>DS</sub> (V)

#### **RESTRICTIONS ON PRODUCT USE**

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